

Supporting Information

Asymmetric TMO–Metal–TMO Structure for Enhanced Efficiency and Long-term Stability of Si-Based Heterojunction Solar Cells

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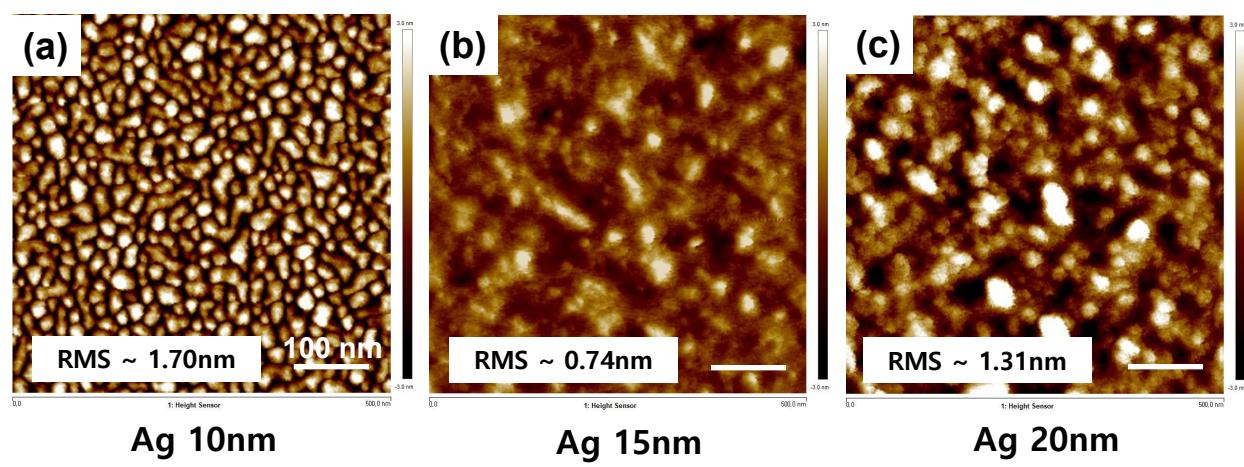


Figure S1. AFM images of Ag layers deposited on MO surface: (a) 10nm, (b) 15nm, and (c) 20nm.

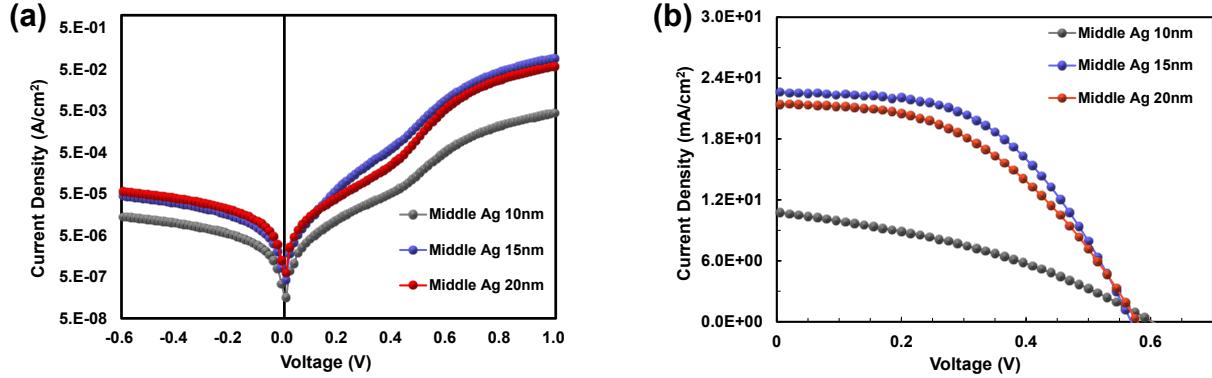


Figure S2. J–V curves of the TMT/Si HSCs according to the middle Ag layer thickness under (a) dark and (b) illumination (AM1.5) conditions.

Table S1. Solar cell characteristic parameters of the TMT/Si HSCs according to the middle Ag layer thickness under illumination (AM1.5) conditions.

MO/Ag/VO	J_{sc} (mA/cm^2)	V_{oc} (mV)	FF (%)	R_{sh} ($\Omega \cdot \text{cm}^2$)	R_s ($\Omega \cdot \text{cm}^2$)	PCE (%)
8 nm/10nm/55 nm	10.79	603	36.10	10795	23.66	2.35
8 nm/15 nm/55 nm	23.24	574	56.78	23207	2.91	7.57
8 nm/20 nm/55 nm	21.44	579	46.04	21567	4.72	5.72